

# WPAT65N640-HAF

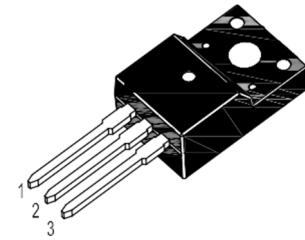
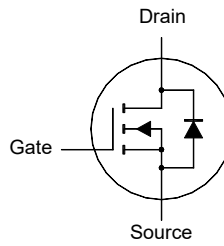
## N-Channel Enhancement Mode MOSFET

### Features

- Low  $R_{DS(on)}$
- Low Gate Charge
- Halogen and Antimony Free(HAF), RoHS compliant

### Application

- DC-DC converters
- Lighting



1.Gate 2.Drain 3.Source  
TO-220F Plastic Package

### Key Parameters

Parameter	Value	Unit
$BV_{DSS}$	650	V
$R_{DS(ON) Max}$	0.64 @ $V_{GS} = 10 V$	$\Omega$
$V_{GS(th) typ}$	3	V
$Q_g typ$	10 @ $V_{GS} = 10 V$	nC

### Absolute Maximum Ratings(at $T_a = 25^\circ C$ unless otherwise specified)

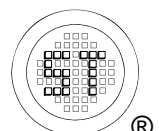
Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	650	V
Gate-Source Voltage	$V_{GS}$	$\pm 30$	V
Drain Current	$I_D$	$T_c = 25^\circ C$ 3.2 $T_c = 100^\circ C$ 2	A
Peak Drain Current, Pulsed <sup>1)</sup>	$I_{DM}$	20	A
Avalanche Current	$I_{AS}$	2.1	A
Single Pulse Avalanche Energy <sup>2)</sup>	$E_{AS}$	174	mJ
Power Dissipation	$P_D$	$T_c = 25^\circ C$ 17.9	W
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to + 150	$^\circ C$

### Thermal Characteristics

Parameter	Symbol	Max.	Unit
Thermal Resistance from Junction to Case	$R_{\theta JC}$	6.9	$^\circ C/W$
Thermal Resistance from Junction to Ambient	$R_{\theta JA}$	45	$^\circ C/W$

<sup>1)</sup> Pulse Test: Pulse Width  $\leq 100 \mu s$ , Duty Cycle  $\leq 2\%$ , Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)} = 150^\circ C$ .

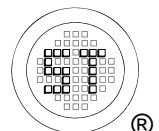
<sup>2)</sup> Limited by  $T_{J(MAX)}$ , starting  $T_J = 25^\circ C$ ,  $L = 79 mH$ ,  $R_g = 25 \Omega$ ,  $I_{AS} = 2.1 A$ ,  $V_{GS} = 10 V$ .



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Characteristics at  $T_a = 25^\circ\text{C}$  unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit
<b>STATIC PARAMETERS</b>					
Drain-Source Breakdown Voltage at $I_D = 250 \mu\text{A}$	$BV_{DSS}$	650	-	-	V
Drain-Source Leakage Current at $V_{DS} = 520 \text{ V}$	$I_{DSS}$	-	-	1	$\mu\text{A}$
Gate Leakage Current at $V_{GS} = \pm 24 \text{ V}$	$I_{GSS}$	-	-	$\pm 100$	nA
Gate-Source Threshold Voltage at $V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	$V_{GS(th)}$	2	-	4	V
Drain-Source On-State Resistance at $V_{GS} = 10 \text{ V}$ , $I_D = 3.5 \text{ A}$	$R_{DS(on)}$	-	0.57	0.64	$\Omega$
<b>DYNAMIC PARAMETERS</b>					
Forward Transconductance at $V_{DS} = 5 \text{ V}$ , $I_D = 3.5 \text{ A}$	$g_{FS}$	-	4.2	-	S
Gate Resistance at $V_{GS} = 0 \text{ V}$ , $V_{DS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$	$R_g$	-	5.8	-	$\Omega$
Input Capacitance at $V_{GS} = 0 \text{ V}$ , $V_{DS} = 300 \text{ V}$ , $f = 1 \text{ MHz}$	$C_{iss}$	-	399	-	pF
Output Capacitance at $V_{GS} = 0 \text{ V}$ , $V_{DS} = 300 \text{ V}$ , $f = 1 \text{ MHz}$	$C_{oss}$	-	25	-	pF
Reverse Transfer Capacitance at $V_{GS} = 0 \text{ V}$ , $V_{DS} = 300 \text{ V}$ , $f = 1 \text{ MHz}$	$C_{rss}$	-	4.9	-	pF
Gate charge total at $V_{DS} = 325 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 3.5 \text{ A}$	$Q_g$	-	10	-	nC
Gate to Source Charge at $V_{DS} = 325 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 3.5 \text{ A}$	$Q_{gs}$	-	2.7	-	nC
Gate to Drain Charge at $V_{DS} = 325 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 3.5 \text{ A}$	$Q_{gd}$	-	3.6	-	nC
Turn-On Delay Time at $V_{DS} = 325 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 3.5 \text{ A}$ , $R_G = 24 \Omega$	$t_{d(on)}$	-	22	-	ns
Turn-On Rise Time at $V_{DS} = 325 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 3.5 \text{ A}$ , $R_G = 24 \Omega$	$t_r$	-	14	-	ns
Turn-Off Delay Time at $V_{DS} = 325 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 3.5 \text{ A}$ , $R_G = 24 \Omega$	$t_{d(off)}$	-	17	-	ns
Turn-Off Fall Time at $V_{DS} = 325 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 3.5 \text{ A}$ , $R_G = 24 \Omega$	$t_f$	-	51	-	ns
<b>Body-Diode PARAMETERS</b>					
Drain-Source Diode Forward Voltage at $I_S = 1 \text{ A}$ , $V_{GS} = 0 \text{ V}$	$V_{SD}$	-	-	1.4	V
Body-Diode Continuous Current	$I_S$	-	-	3.2	A
Body-Diode Continuous Current, Pulsed	$I_{SM}$	-	-	20	A
Body Diode Reverse Recovery Time at $I_S = 3.5 \text{ A}$ , $di/dt = 100 \text{ A} / \mu\text{s}$	$t_{rr}$	-	275	-	ns
Body Diode Reverse Recovery Charge at $I_S = 3.5 \text{ A}$ , $di/dt = 100 \text{ A} / \mu\text{s}$	$Q_{rr}$	-	1.5	-	$\mu\text{C}$



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## Electrical Characteristics Curves

Fig. 1 Typical Output Characteristics

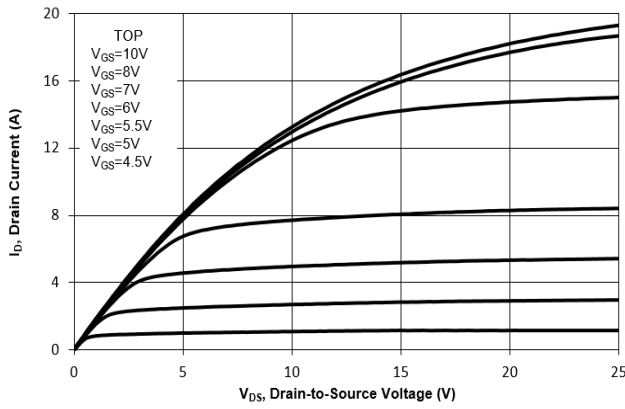


Fig. 2 Typical Transfer Characteristics

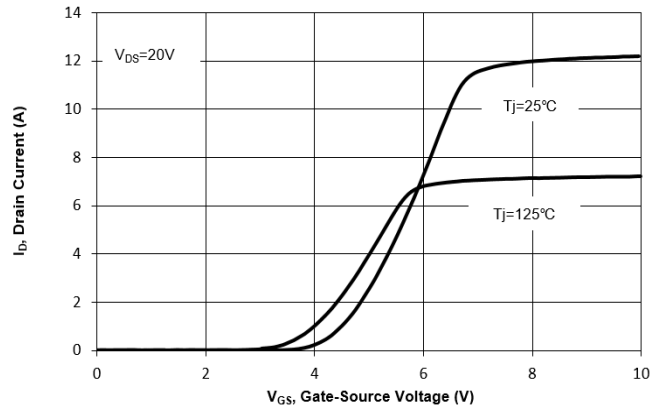


Fig. 3 On-Resistance vs. Drain Current

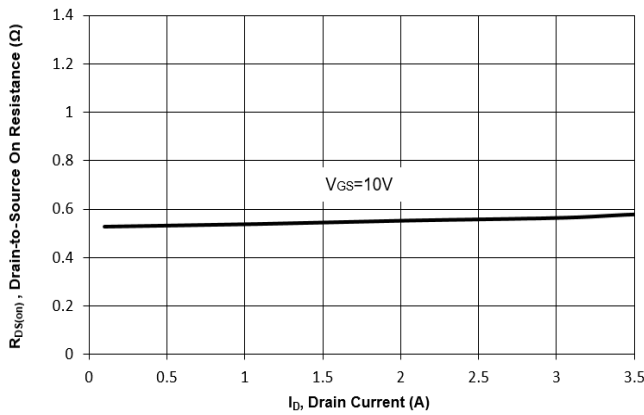


Fig. 4 On-Resistance vs. Gate to Source Voltage

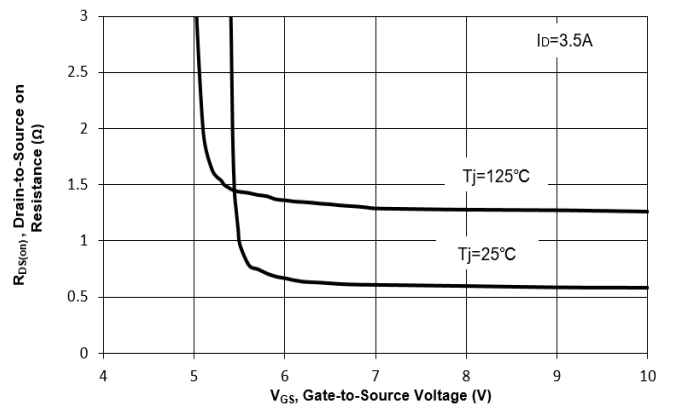


Fig. 5 On-Resistance vs.  $T_j$

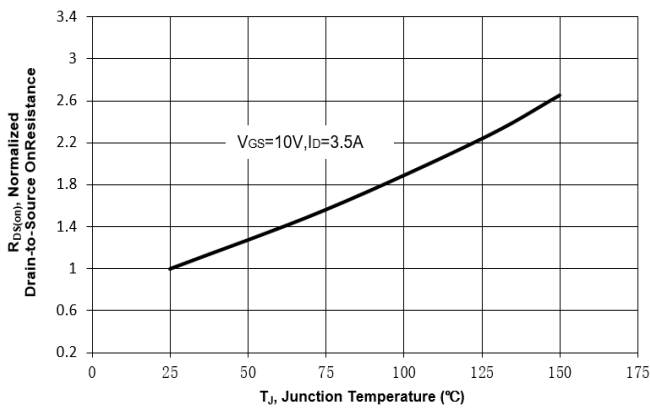
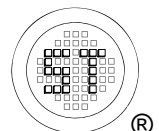
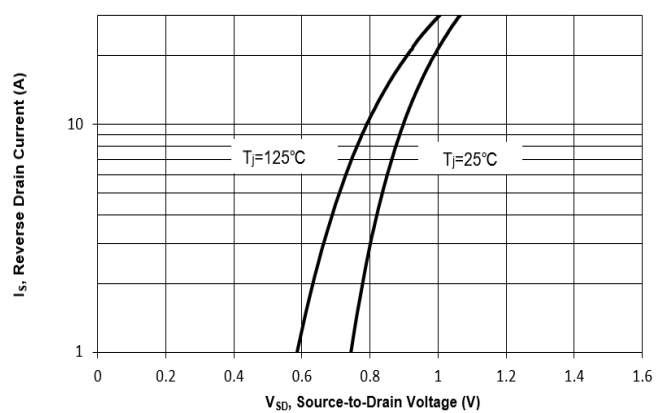


Fig. 6 Typical Body-Diode Forward Characteristics



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## Electrical Characteristics Curves

Fig. 7 Typical Junction Capacitance

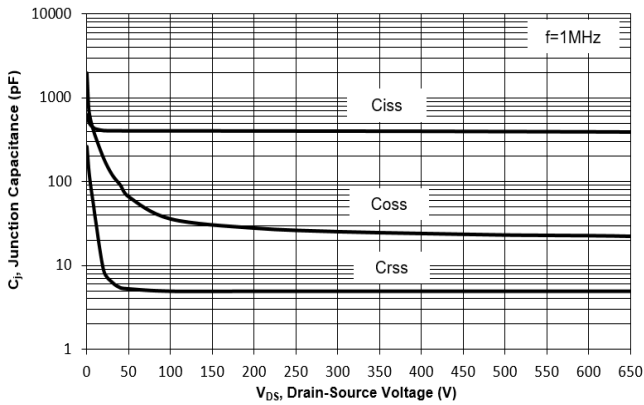


Fig. 8 Drain-Source Leakage Current vs. Tj

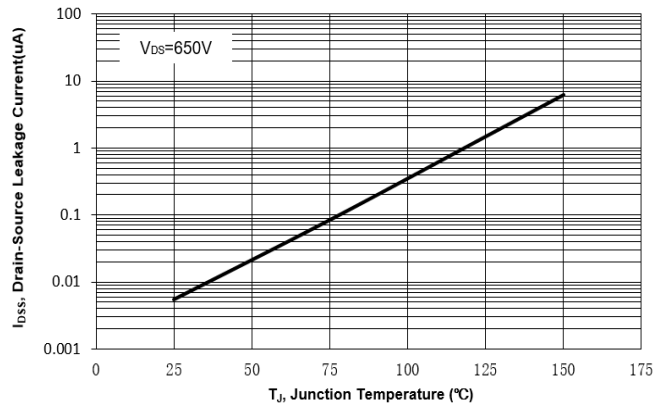


Fig. 9 V(BR)DSS vs. Junction Temperature

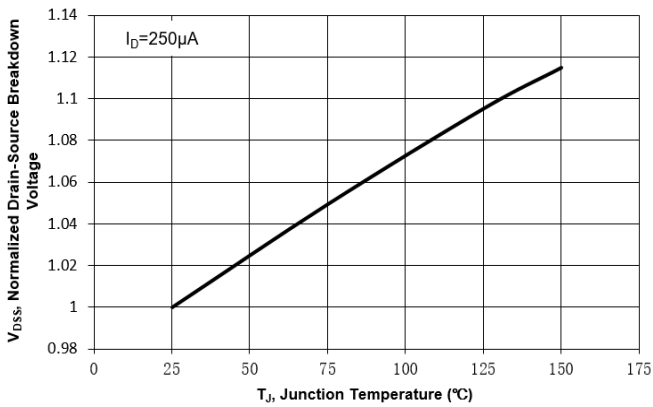


Fig. 10 Gate Threshold Variation vs. Tj

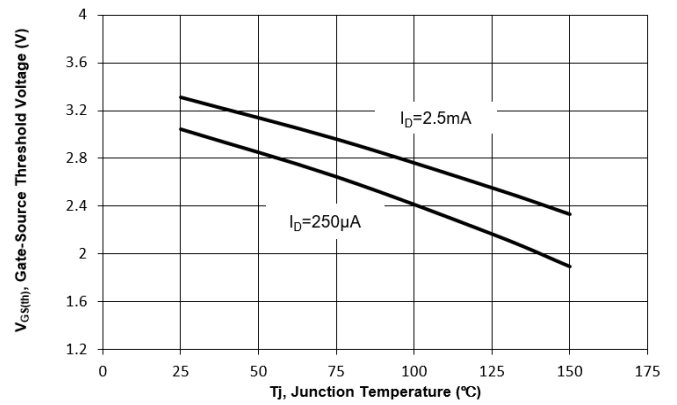


Fig. 11 Gate Charge

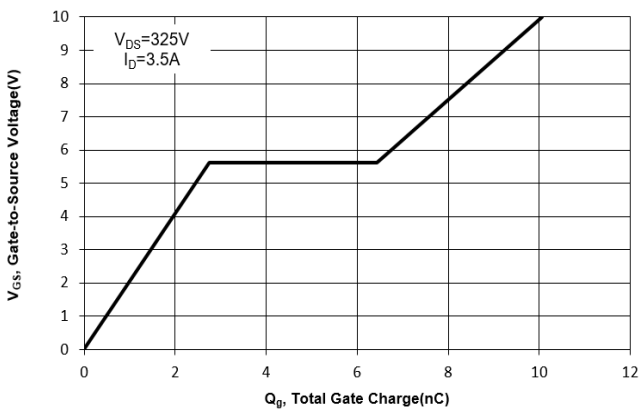
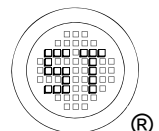
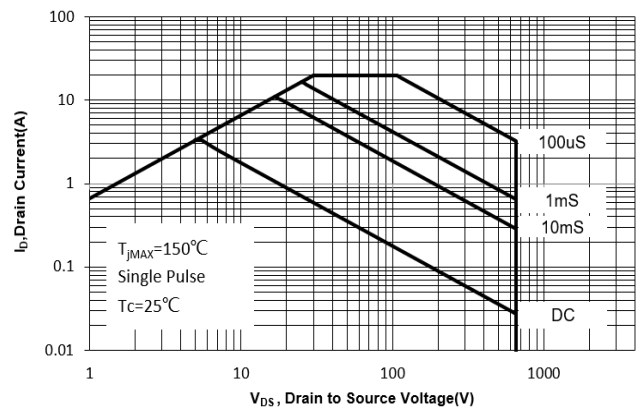


Fig. 12 Safe Operation Area



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## Electrical Characteristics Curves

Fig.13 Normalized Maximum Transient Thermal Impedance( $Z_{\theta JC}$ )

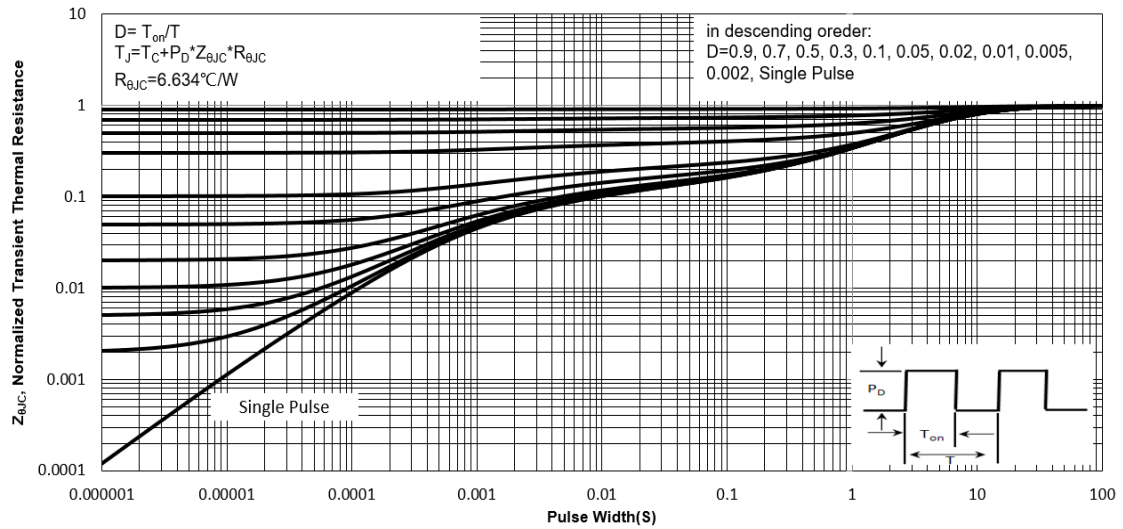
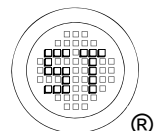
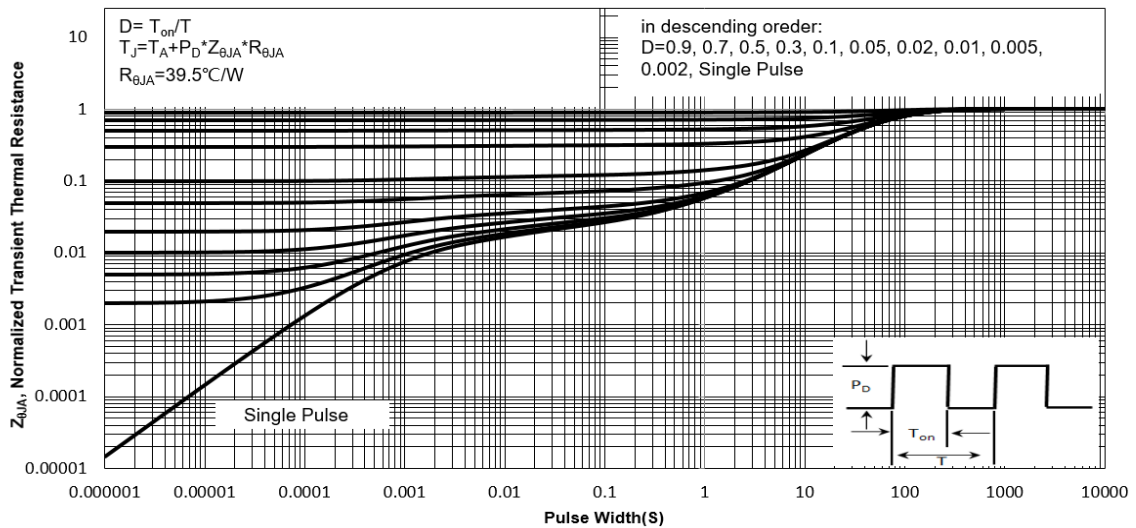


Fig.14 Normalized Maximum Transient Thermal Impedance( $Z_{\theta JA}$ )



## Test Circuits

Fig.1-1 Switching times test circuit

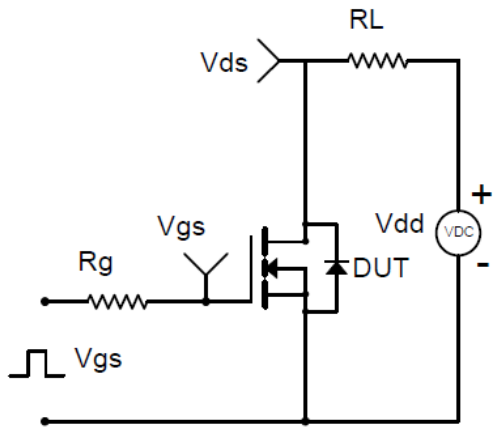


Fig.1-2 Switching Waveform

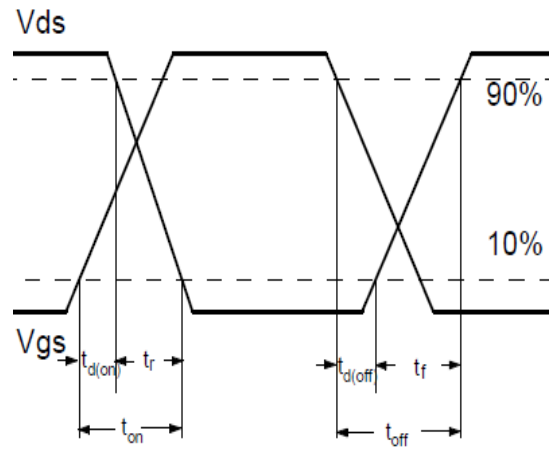


Fig.2-1 Gate charge test circuit

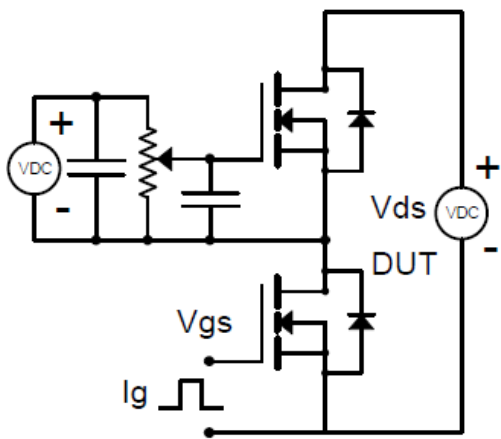


Fig.2-2 Gate charge waveform

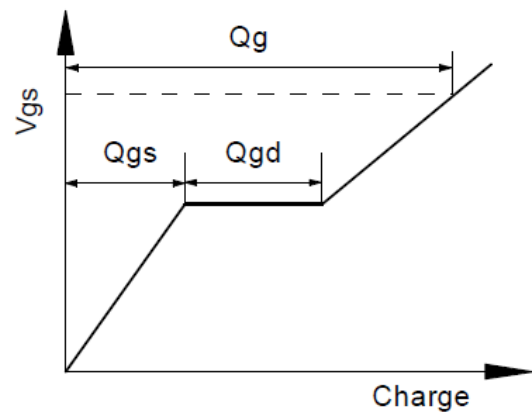


Fig.3-1 Avalanche test circuit

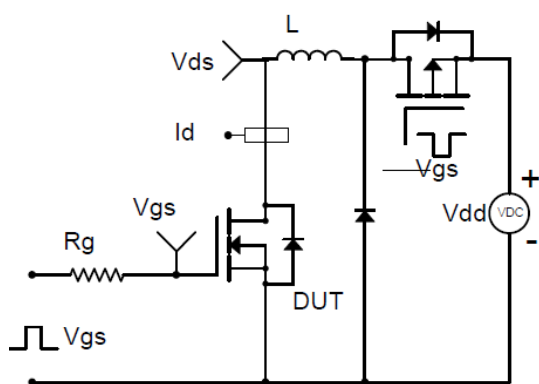


Fig.3-2 Avalanche waveform

